

<b>Notice of References Cited</b>	Application/Control No. 10/691,150		Applicant(s)/Patent Under Reexamination HWANG ET AL.	
	Examiner MINH D. A		Art Unit 2821	Page 1 of 1

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*	B	US-6,459,916	10-2002	Suguro, Akihiro	455/575.7
*	C	US-6,239,755	05-2001	Klemens et al.	343/702
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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